

### N-Channel 30-V (D-S) MOSFET

### Description

The MS34N00 is the highest performance trench N-ch MOSFETs with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the small power switching and load switch applications.

The device meets the RoHS and Green Product requirement with full function reliability approved.

#### Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

#### **Typical Applications**

- Battery Protection
- Load Switch
- Hand-held Instrument

### Package type : SOT-23

AEC-Q101 qualified available

- Automotive ordering code: base /H3

### Packing & Order Information

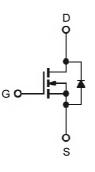
3,000/Reel



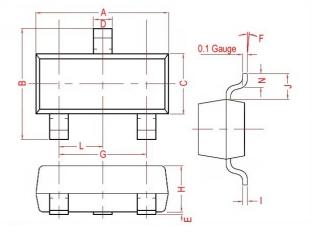




**Graphic Symbol** 

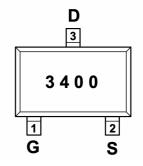


#### **Package Dimension**



REF.	Millimeter		REF.	Millimeter		
	Min.	Max.	REF.	Min.	Max.	
Α	2.70	3.10	G	1.90 Ref.		
В	2.30	3.00	Н	0.90	1.30	
С	1.20	1.75	I	0.05	0.21	
D	0.30	0.50	J	0.58 Ref.		
E	0.01	0.15	L	0.95 Typ.		
F	0°	10°	N	0.20 Min.		

#### Marking





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### MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings (unless otherwise specified)					
Symbol	Parameter	Value	Units		
V <sub>DS</sub>	Drain-Source Voltage	30	V		
$V_{GS}$	Gate-Source Voltage	±12	V		
1_	Continuous Drain Current (T <sub>A</sub> =25°C)	5.8	A		
ID	Continuous Drain Current (T <sub>A</sub> =70°C)	4.9	А		
IDM	Pulsed Drain Current <sup>2</sup> (T <sub>A</sub> =25°C)	23	А		
PD	Power Dissipation <sup>3</sup> (T <sub>A</sub> =25°C)	1	W		
TJ/Tstg	Operating Junction and Storage Temperature	-55 to +150	°C		

Thermal Resistance Ratings					
Symbol	Parameter	Maximum	Units		
R <sub>0JA</sub>	Maximum Junction-to-Ambient <sup>1</sup>	125	°C/W		
R <sub>θJA</sub>	Maximum Junction-to-Ambient <sup>1</sup> (t ≤10s)	85	°C/W		

Electrical Characteristics(T」=25°C unless otherwise specified)						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
VGS (th)	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250µA	0.5	-	1.5	V
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA	30	-	-	V
<b>g</b> fs	Forward Transconductance	V <sub>DS</sub> =5V, I <sub>D</sub> =5A	-	25	-	S
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 12V$	-	-	±100	nA
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C V <sub>DS</sub> =24V, V <sub>GS</sub> =0V, T <sub>J</sub> =55°C	-	-	1 5	μA
RDS (on)	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =10V, I <sub>D</sub> =5.0A V <sub>GS</sub> =4.5V, I <sub>D</sub> =5.0A V <sub>GS</sub> =2.5V, I <sub>D</sub> =2.6A	-	-	26 30 45	mΩ
Vsd	Diode Forward Voltage <sup>2</sup>	I <sub>S</sub> =1.2A, V <sub>GS</sub> =0V, T <sub>J</sub> =25°C	-	-	1.2	V
ls	Continuous Source Current <sup>1,4</sup> (Diode)	$V_G = V_D = 0V$ , Force Current	-	-	5.8	Α

#### Notes

1. Surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.

- 2. The data tested by pulsed, pulse width  $\leq$  300us, duty cycle  $\leq$  2%.
- 3. The power dissipation is limited by 150  $^\circ\!\!\mathbb{C}$  junction temperature.
- 4. The data is theoretically the same as I<sub>D</sub> and I<sub>DM</sub>, in real applications, should be limited by total power dissipation.



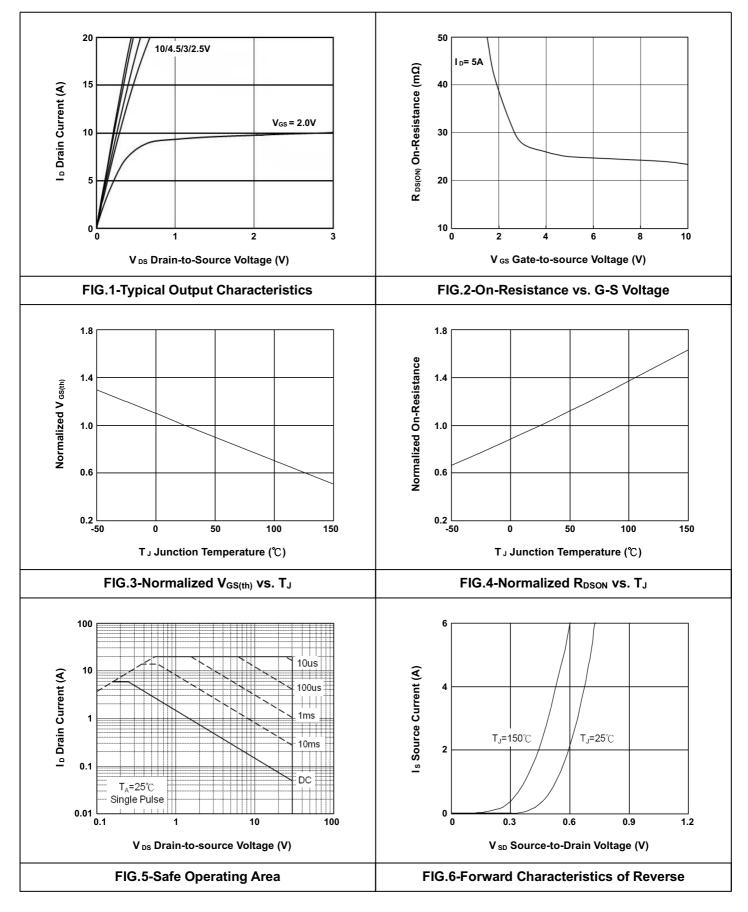
### N-Channel 30-V (D-S) MOSFET

Dynamic and switching Characteristics						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Qg	Total Gate Charge	V <sub>DS</sub> =15V		11.5		
Qgs	Gate-Source Charge	I <sub>D</sub> =5.8A		1.6		nC
Q <sub>gd</sub>	Gate-Drain Charge	V <sub>GS</sub> =4.5V		2.9		
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DS</sub> =15V		5		
tr	Rise Time	I <sub>D</sub> =5A		47		
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> =10V		26		ns
t <sub>f</sub>	Fall Time	$R_G = 3\Omega$		8		
Ciss	Input Capacitance	V <sub>DS</sub> =15V		860		
Coss	Output Capacitance	V <sub>GS</sub> =0V		84		pF
Crss	Reverse Transfer Capacitance	f =1.0MHz		70		



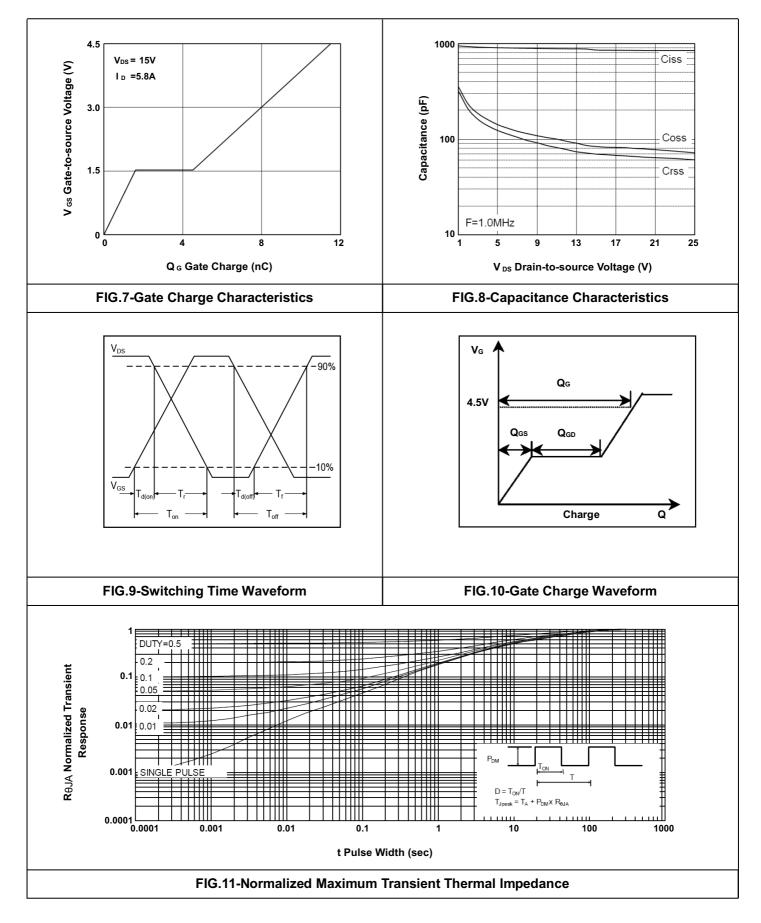
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• Typical Electrical Characteristics





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